



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Wayne Renken
Assignee: SensArray Corporation
Title: Process Condition Sensing Wafer and Data Analysis System
Application No.: 10/056,906 Filing Date: January 24, 2002
Examiner: Garber, Charles D. Group Art Unit: 2856
Docket No.: SENS.005US0 Conf. No.: 2359
(formerly M-12467 US)

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RESPONSE TO EXAMINER'S REASONS FOR ALLOWANCE

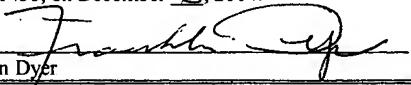
Dear Sir:

The Notice of allowance and fee(s) due in this case, dated September 7, 2004 included the Examiner's statement of reasons for allowance. The statement appears to accurately reflect the discussion between the Examiner and the undersigned attorney regarding the terms "including" and "encompassing" in the limitation "the electronics platform including/encompassing at lease one integrated circuit" of claim 55. It is submitted that the Examiner has given an unreasonably broad meaning to the term "including" in this limitation. In particular, the Examiner viewed a platform that was a component of a circuit as a an example of a "platform including a circuit. "Exminer took the position of broadly taking 'including' to mean the electrode (platform) need only comprise a portion of the circuit as a part of a whole circuit," reasons for allowance page 3. This definition would appear to mean that any component in an assembly "includes" the assembly and is thus believed to be beyond the reasonable meaning of the term "including." Because the term "including" is not believed to have the broad meaning attributed to it by the Examiner, it is submitted that the replacement of "including" by

"encompassing" does not narrow the scope of claim 55. Thus, claim 55 as amended is submitted to be at least as broad as it was prior to this amendment.

Certificate of Mailing Under 37 CFR 1.8

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on December 6, 2004.


Franklin Dyer

Respectfully submitted,



Peter A. Gallagher
Reg. No.47,584

12/6/04

Date

December 6, 2004

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Dear Sir:

Transmitted herewith are the following documents in the above-identified application:

- (1) Return Receipt Postcard;
- (2) This Transmittal Letter (in duplicate);
- (3) Issue Fee Transmittal (1 page-in duplicate);
- (4) Response To Examiner's Reasons For Allowance (2 pages); and
- (5) Check for \$994.00

The fee has been calculated as shown below:

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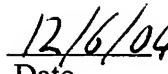
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